# RS5N65F

VDSS

650V

## **N** Channel MOSFET

## **Applications:**

- •Adapter & Charger
- •AC-DC Switching Power Supply
- LED driving power
- •PC Power Supply

#### Features:

- •100% avalanche tested
- •Ultra low gate Charge(typical 14nC)
- •Low Cress(typical 5.4pF)
- •Fast switching capability
- •RoHS Compliant

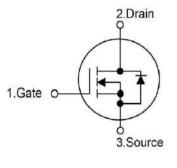
**Ordering Information** 

| Part Number | Package | Marking |
|-------------|---------|---------|
| RS5N65F     | TO-220F | RS5N65F |



lр

5A



Lead Free Package and Finish

Not to Scale

(96)

RDS(ON)(Typ.)

1.9Ω

#### Absolute Maximun Ratings Tc=25°C unless otherwise specified

| Symbol      | Parameter  | RS5N65F    | Units |
|-------------|--|------------|-------|
| VDSS        | Drain-to-Source Voltage (Note*1)   | 650        | V     |
| ID          | Continuous Drain Current   | 5          |       |
| ID@ 100 ℃   | Continuous Drain Current   | 3.2        | A     |
| ldм         | Pulsed Drain Current (Note*2)  | 20         |       |
| DD          | Power Dissipation  | 38         | W     |
| PD          | Derating Factor above 25℃  | 0.3        | W/°C  |
| VGS         | Gate-to-Source Voltage   | ±30        | V     |
| EAS         | Single Pulse Avalanche Engergy<br>L=29mH IAS=5A VDD=50V RG=25Ω TJ=25℃                        | 232        | mJ    |
| EAR         | Repetitve Pulse Avalanche Engergy<br>(pulse width limied by maximum junction<br>temperature) | 15         | mJ    |
|             | Maximum Temperature for Soldering  |            |       |
| TL<br>TPKG  | Leads at 0.063in(1.6mm)from Case for 10 seconds  | 300<br>260 | ĉ     |
|             | Package Body for 10 seconds  |            | C     |
| TJ and TSTG | Operating Junction and Storage   | -55 to 150 |       |
|             | Temperature Range  | -33 10 130 |       |

\*Drain Current Limited by Maximum Junction Temperature

Caution:Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.

#### **Thermal Resistance**

| Symbol | Parameter           | RS5N65F | Units | Test Conditions   |
|--------|---------------------|---------|-------|---|
| Rejc   | Junction-to-Case    | 3.29    | °C/W  | Drain lead soldered to water<br>cooled heatsink,PD<br>adjusted for a peak junction<br>temperature of +150℃. |
| Reja   | Junction-to-Ambient | 120     |       | 1 cubic foot chamber, free air.   |

## OFF Characteristics TJ=25°C unless otherwise specified

| Symbol | Parameter                         |      | Тур. | Max. | Units | <b>Test Conditions</b> |
|--------|-----------------------------------|------|------|------|-------|------------------------|
| BVDSS  | Drain-to-source Breakdown Voltage | 650  |      |      | V     | Vgs=0V,Id=250µA        |
| ldss   | Drain-to-Source Leakage Current   |      |      | 1.0  | μA    | VDS=650V,VGS=0V        |
|        | Gate-to-Source Forward Leakage    | kage |      | 100  | n۸    | VGS=+30V VDS=0V        |
| IGSS   | Gate-to-Source Reverse Leakage    |      |      | -100 | nA    | VGS=-30V VDS=0V        |

## ON Characteristics TJ=25℃ unless otherwise specified

| Symbol  | Parameter                            |  | Тур. | Max. | Units | Test Conditions  |
|---------|--------------------------------------|--|------|------|-------|------------------|
| RDS(on) | Static Drain-to-Source On-Resistance |  | 1.90 | 2.40 | Ω     | VGS=10V,ID=2.5A  |
| Vgs(TH) | Gate Threshold Voltage               |  |      | 4.0  | V     | Vgs=Vds,Id=250µA |
| Gfs     | Forward Transconductance             |  | 2.5  |      | S     | VDS=50V,ID=2.5A  |

## **Resistive Switching Characteristics** Essentially independent of operating temperature

| Symbol  | Parameter           | Min. | Тур. | Max. | Units | Test Conditions                           |
|---------|---------------------|------|------|------|-------|---|
| td(ON)  | Turn-on Delay Time  |      | 15   |      |       | VDS=325V<br>ID=5A<br>RG=10Ω<br>(Note:3,4) |
| trise   | Rise Time           |      | 30   |      | nS    |   |
| td(OFF) | Turn-OFF Delay Time |      | 20   |      | 110   |   |
| tfall   | Fall Time           |      | 14   |      |       |   |

## Dynamic Characteristics Essentially independent of operating temperature

| Symbol | Parameter                      | Min. | Тур. | Max. | Units | Test Conditions                |
|--------|--------------------------------|------|------|------|-------|--------------------------------|
| Ciss   | Input Capacitance              |      | 570  |      |       | Vgs=0V                         |
| Coss   | Output Capacitance             |      | 56   |      | pF    | VDS=25V                        |
| Crss   | Reverse Transfer Capacitance   |      | 5.4  |      |       | f=1.0MHz                       |
| Qg     | Total Gate Charge              |      | 14   |      |       | VDS=520V                       |
| Qgs    | Gate-to-Source Charge          |      | 3.8  |      | nC    | ID=5A<br>VGS=10V<br>(Note:3,4) |
| Qgd    | Gate-to-Drain("Miller") Charge |      | 7.5  |      |       |                                |



## Source-Drain Diode Characteristics

| Symbol | Parameter                 | Min. | Тур. | Max. | Units | Test Conditions     |
|--------|---------------------------|------|------|------|-------|---------------------|
| ls     | Continuous Source Current |      |      | 5    | Α     | Integral pn-diode   |
| Ism    | Maximum Pulsed Current    |      |      | 20   | Α     | in MOSFET           |
| Vsd    | Diode Forward Voltage     |      |      | 1.4  | V     | Is=5A,Vgs=0V        |
| trr    | Reverse Recovery Time     |      | 513  |      | nS    | Vgs=0V              |
| Qrr    | Reverse Recovery Charge   |      | 2.6  |      | μC    | Is=5A,di/dt=100A/µs |

#### Notes:

\*1.TJ=±25℃ to +150℃.

\*2.Repetitive rating; pulse width limited by maximum junction temperature.

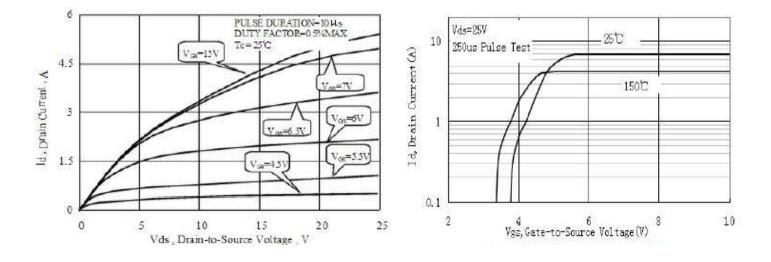
\*3.Pulse width  $\leq$  300µs; duty cycle  $\leq$  2%.

\*4.Basically not affected by temperature.

## **Typical Feature curve**

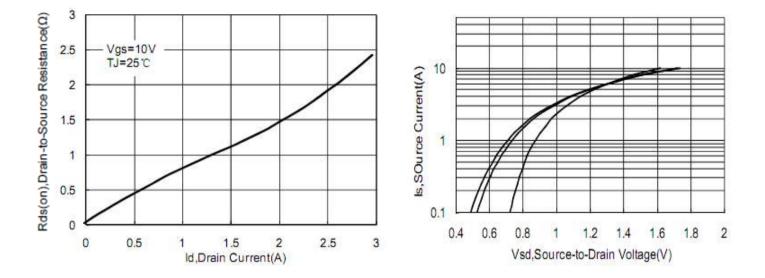
Figure1.TypicalOutput Characteistics

## Figure2.Typical Transfer Characteristics





RS5N65F



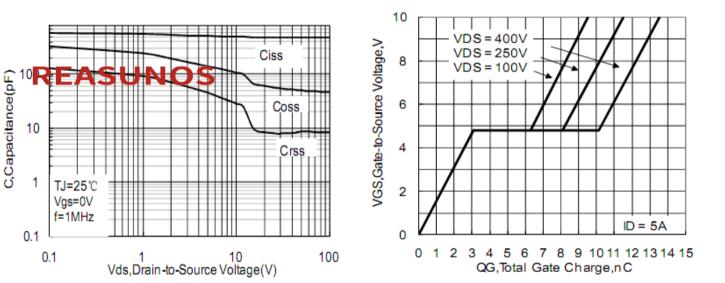
Figuer3.Typical ON Resistance vs Drain Current

Figure5.Typical Capacitance vs Drainto-Source Voltage

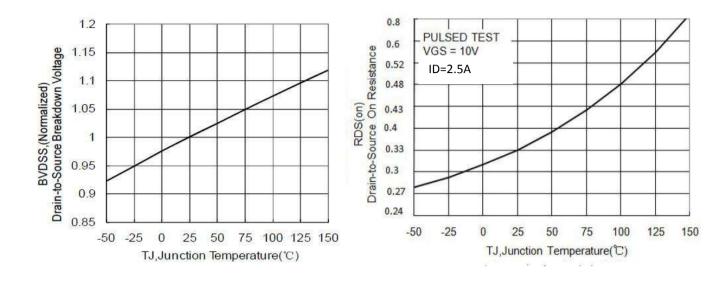
Figure6.Typical Gate Charge vs Gateto-Source Voltage

Figuer4.Typical Body Diode Transfer

Characteristics





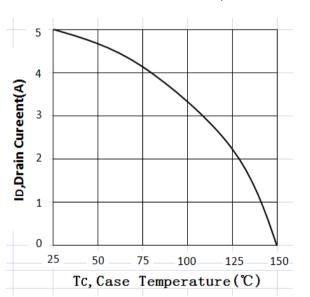


#### Figure7. Typical Breakdown Voltage vs Junation Temperature



#### Figure9.Maximum Continuous Drain Current vs Case Temperature

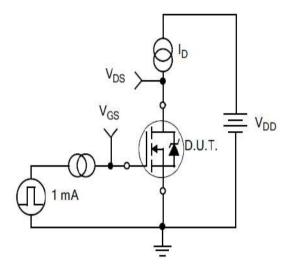
Figure10.Maximum Safe Operating Area



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## **Test Circuits and Waveforms**



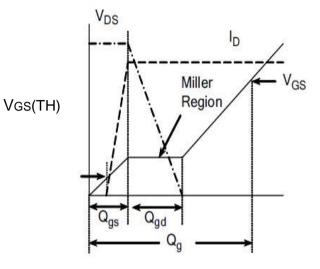


Figure11. Gate Charge Test Circuit

Figure12. Gate Charge Waveform

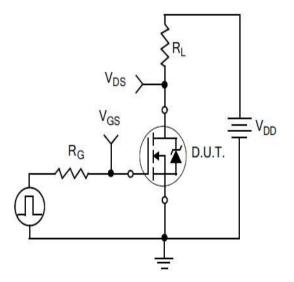


Figure13. Resistive Switching Test Circuit

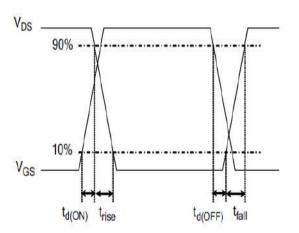


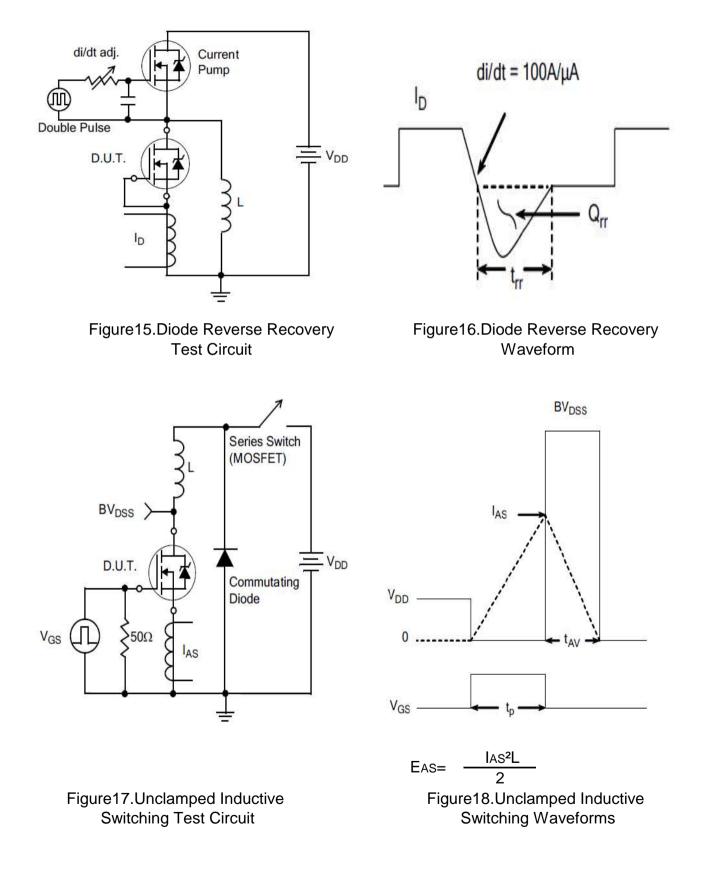
Figure14. Resistive Switching Waveforms

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RS5N65F

## **Test Circuits and Waveforms**

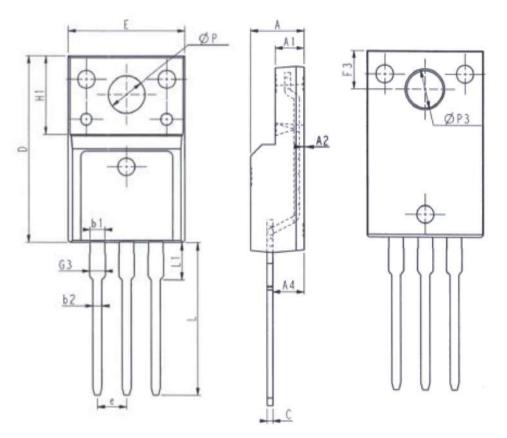




## Package outline drawing

Unit:mm

TO-220F



| Unit: mm |       |       | Unit: mm |                     |       |  |
|----------|-------|-------|----------|---------------------|-------|--|
| Symbol   | Min.  | Max.  | Symbol   | Min.                | Max.  |  |
| E        | 9.96  | 10.36 | L        | 12. 68              | 13.28 |  |
| A        | 4.50  | 4.90  | L1       | 2.93                | 3.13  |  |
| A1       | 2.34  | 2.74  | P        | 3.03                | 3.38  |  |
| A2       | 0.30  | 0.60  | P3       | 3.15                | 3.65  |  |
| A4       | 2.56  | 2.96  | F3       | 3. <mark>1</mark> 5 | 3.45  |  |
| С        | 0.40  | 0.65  | G3       | 1.25                | 1.55  |  |
| D        | 15.57 | 16.17 | b1       | 1.18                | 1.43  |  |
| H1       | 6. 70 | OREF  | b2       | 0.70                | 0.95  |  |
| e        | 2. 54 | 4BSC  | 63<br>   |                     |       |  |

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